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8/98—Rev. 0 to Rev. A

SPECIFICATIONS

 V_{DD} = 5 V \pm 10%, GND = 0 V. Temperature range for B version is -40° C to $+85^{\circ}$ C, unless otherwise noted.

Table 2.

	B Version				
Parameter	+25°C	−40°C to +85°C	Unit	Test Conditions/Comments	
ANALOG SWITCH	+25 C	+65 C	Onit	rest conditions/comments	
Analog Signal Range		0 V to V _{DD}	V		
On Resistance (R _{ON})	2	0 0 10 000	ν Ω typ	$V_S = 0 \text{ V to } V_{DD}, I_S = -10 \text{ mA}; \text{ Figure } 11$	
Off Resistance (N _{ON})	3	4	$\Omega \max$	vs = 0 v to vDD, is = -10 mA, Figure 11	
On Resistance Flatness (R _{FLAT(ON)})	0.5	4		$V_S = 0 \text{ V to } V_{DD}, I_S = -10 \text{ mA}$	
Off Resistance Flattiess (R _{FLAT(ON)})	0.5	1.0	Ω typ $Ω$ max	$\mathbf{v}_{S} = 0 \mathbf{v}$ to \mathbf{v}_{DD} , $\mathbf{i}_{S} = -10 \text{ HIA}$	
LEAKAGE CURRENTS		1.0	12 max	V _{DD} = 5.5 V	
	±0.01		A	1	
Source OFF Leakage, Is (OFF)			nA typ	$V_S = 4.5 \text{ V/1 V}, V_D = 1 \text{ V/4.5 V};$ Figure 12	
Drain OFF Leakage, I _D (OFF)	±0.01		nA typ	$V_S = 4.5 \text{ V/1 V}, V_D = 1 \text{ V/4.5 V};$ Figure 12	
Channel ON Leakage, I _D , I _S (ON)	±0.01		nA typ	$V_S = V_D = 1 \text{ V, or } 4.5 \text{ V; Figure } 13$	
DIGITAL INPUTS					
Input High Voltage, V _{INH}		2.4	V min		
Input Low Voltage, V _{INL}		0.8	V max		
Input Current					
I _{INL} or I _{INH}	0.005		μA typ	$V_{IN} = V_{INL} \text{ or } V_{INH}$	
		±0.1	μA max		
DYNAMIC CHARACTERISTICS ¹					
ton	12		ns typ	$R_L = 300 \Omega, C_L = 35 pF$	
		18	ns max	$V_S = 3 V$; Figure 14	
toff	8		ns typ	$R_L = 300 \Omega$, $C_L = 35 pF$	
		12	ns max	$V_S = 3 V$; Figure 14	
Charge Injection	5		pC typ	$V_S = 2 \text{ V}, R_S = 0 \Omega, C_L = 1 \text{ nF; Figure 15}$	
Off Isolation	-55		dB typ	$R_L = 50 \Omega$, $C_L = 5 pF$, $f = 10 MHz$	
	-75		dB typ	$R_L = 50 \Omega$, $C_L = 5 pF$, $f = 1 MHz$; Figure 16	
Bandwidth –3 dB	200		MHz typ	$R_L = 50 \Omega$, $C_L = 5 pF$; Figure 17	
C _s (OFF)	17		pF typ		
C _D (OFF)	17		pF typ		
C_D , C_S (ON)	38		pF typ		
POWER REQUIREMENTS				$V_{DD} = 5.5 \text{ V}$	
				Digital inputs = 0 V or 5 V	
I_{DD}	0.001		μA typ		
		1.0	μA max		

 $^{^{\}rm 1}$ Guaranteed by design, not subject to production test.

 $V_{DD} = 3 \text{ V} \pm 10\%$, GND = 0 V. Temperature range for B version is -40°C to $+85^{\circ}\text{C}$, unless otherwise noted.

Table 3.

	B Version				
		−40°C to			
Parameter	+25°C	+85°C	Unit	Test Conditions/Comments	
ANALOG SWITCH					
Analog Signal Range		$0 V to V_{DD}$	V		
On Resistance (R _{ON})	3.5		Ω typ	$V_S = 0 \text{ V to } V_{DD}$, $I_S = -10 \text{ mA}$; Figure 11	
	5	6	Ω max		
On Resistance Flatness (R _{FLAT(ON)})	1.5		Ωtyp	$V_S = 0 \text{ V to } V_{DD}$, $I_S = -10 \text{ mA}$	
LEAKAGE CURRENTS				$V_{DD} = 3.3 \text{ V}$	
Source OFF Leakage Is (OFF)	±0.01		nA typ	$V_S = 3 \text{ V/1 V}, V_D = 1 \text{ V/3 V}; \text{ Figure 12}$	
Drain OFF Leakage I _D (OFF)	±0.01		nA typ	$V_S = 3 \text{ V}/1 \text{ V}, V_D = 1 \text{ V}/3 \text{ V}; Figure 12$	
Channel ON Leakage ID, Is (ON)	±0.01		nA typ	$V = V_D = 1 V$, or 3 V; Figure 13	
DIGITAL INPUTS					
Input High Voltage, V _{INH}		2.0	V min		
Input Low Voltage, VINL		0.4	V max		
Input Current					
l _{INL} or l _{INH}	0.005		μA typ	$V_{IN} = V_{INL}$ or V_{INH}	
		±0.1	μA max		
DYNAMIC CHARACTERISTICS ¹					
ton	14		ns typ	$R_L = 300 \Omega$, $C_L = 35 pF$	
		20	ns max	V _s = 2 V, Figure 14	
t _{off}	8		ns typ	$R_L = 300 \Omega, C_L = 35 pF$	
		13	ns max	V _s = 2 V, Figure 14	
Charge Injection	4		pC typ	$V_S = 1.5 \text{ V}, R_S = 0 \Omega, C_L = 1 \text{ nF; Figure 15}$	
Off Isolation	<u> </u>		dB typ	$R_L = 50 \Omega$, $C_L = 5 pF$, $f = 10 MHz$	
	-75		dB typ	$R_L = 50 \Omega$, $C_L = 5 pF$, $f = 1 MHz$; Figure 16	
Bandwidth –3 dB	200		MHz typ	$R_L = 50 \Omega$, $C_L = 5 pF$; Figure 17	
C _s (OFF)	17		pF typ		
C _D (OFF)	17		pF typ		
C_D , C_S (ON)	38		pF typ		
POWER REQUIREMENTS			1 /1	V _{DD} = 3.3 V	
				Digital inputs = 0 V or 3 V	
aal	0.001		μA typ		
		1.0	μA max		

¹ Guaranteed by design, not subject to production test.

ABSOLUTE MAXIMUM RATINGS

 $T_A = +25$ °C, unless otherwise noted.

Table 4.

rable 4.					
Parameter	Rating				
V _{DD} to GND	-0.3 V to +7 V				
Analog and Digital Inputs ¹	$-0.3 \text{ V to V}_{DD} + 0.3 \text{ V}$				
	or 30 mA, whichever				
	occurs first				
Continuous Current, S or D	30 mA				
Peak Current, S or D	100 mA, pulsed at 1 ms,				
	10% duty cycle maximum				
Operating Temperature Range					
Industrial (B Version)	-40°C to +85°C				
Storage Temperature Range	−65°C to +150°C				
Junction Temperature	150°C				
MSOP Package, Power Dissipation	315 mW				
θ_{JA} Thermal Impedance	206°C/W				
θ_{JC} Thermal Impedance	44°C/W				
SOT-23 Package, Power Dissipation	282 mW				
θ_{JA} Thermal Impedance	229.6°C/W				
θ_{JC} Thermal Impedance	91.99°C/W				
Lead Temperature, Soldering					
Vapor Phase (60 sec)	215℃				
Infrared (15 sec)	220°C				
Pb-free Reflow Soldering					
Peak Temperature	260(+0/-5)°C				
Time at Peak Temperature	10 sec to 40 sec				
ESD	2 kV				
	·				

 $^{^{\}rm 1}$ Overvoltages at IN, S, or D are clamped by internal diodes. Current should be limited to the maximum ratings given.

Stresses above those listed under Absolute Maximum Ratings may cause permanent damage to the device. This is a stress rating only; functional operation of the device at these or any other conditions above those indicated in the operational section of this specification is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

Only one absolute maximum rating may be applied at any one time.

Table 5. Truth Table

ADG701 In	ADG702 In	Switch Condition
0	1	Off
1	0	On

ESD CAUTION

ESD (electrostatic discharge) sensitive device. Electrostatic charges as high as 4000 V readily accumulate on the human body and test equipment and can discharge without detection. Although this product features proprietary ESD protection circuitry, permanent damage may occur on devices subjected to high energy electrostatic discharges. Therefore, proper ESD precautions are recommended to avoid performance degradation or loss of functionality.



PIN CONFIGURATIONS AND FUNCTION DESCRIPTIONS

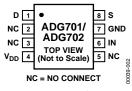






Figure 2. 8-Lead MSOP

Figure 3. 6-Lead SOT-23

Figure 4. 5-Lead SOT-23

Table 6. Pin Descriptions

	Pin No.			
8-Lead MSOP	6-Lead SOT-23	5-Lead SOT-23	Mnemonic	Description
1	1	1	D	Drain Terminal. Can be an input or output.
2, 3, 5	5		NC	No Connect
4	6	5	V_{DD}	Most Positive Power Supply Potential.
6	4	4	IN	Logic Control Input.
7	3	3	GND	Ground (0 V) Reference.
8	2	2	S	Source Terminal. Can be an input or output.

TYPICAL PERFORMANCE CHARACTERISTICS

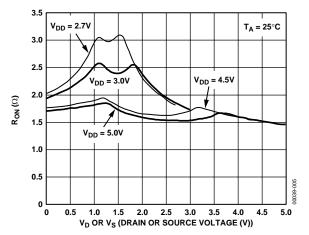


Figure 5. On Resistance as a Function of V_D (V_S) Single Supplies

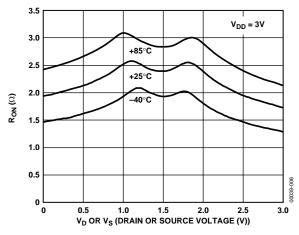


Figure 6. On Resistance as a Function of V_D (V_S) for Different Temperatures $V_{DD} = 3~V$

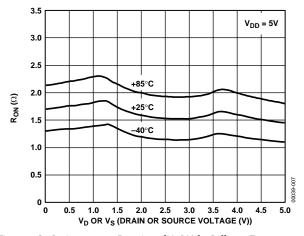


Figure 7. On Resistance as a Function of V_D (V_S) for Different Temperatures $V_{DD} = 5 \ V$

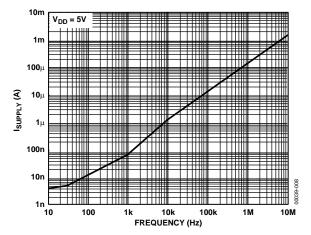


Figure 8. Supply Current vs. Input Switching Frequency

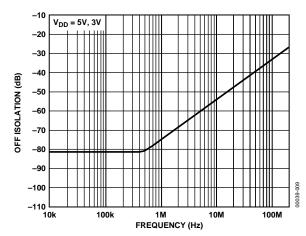


Figure 9. Off Isolation vs. Frequency

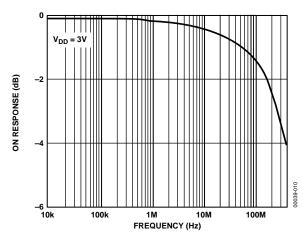


Figure 10. Bandwidth

TERMINOLOGY

Table 7.

Term	Description
Ron	Ohmic resistance between D and S.
R _{FLAT} (ON)	Flatness is defined as the difference between the maximum and minimum value of on resistance as measured over the specified analog signal range.
I _s (OFF)	Source leakage current with the switch off.
I _D (OFF)	Drain leakage current with the switch off.
I_D , I_S (ON)	Channel leakage current with the switch on.
V_D (VS)	Analog voltage on terminals D and S.
C _s (OFF)	Off switch source capacitance.
C _D (OFF)	Off switch drain capacitance.
C_D , C_S (ON)	On switch capacitance.
ton	Delay between applying the digital control input and the output switching on. See Figure 14.
t _{OFF}	Delay between applying the digital control input and the output switching off.
Off Isolation	A measure of unwanted signal coupling through an off switch.
Charge Injection	A measure of the glitch impulse transferred from the digital input to the analog output during switching.
Bandwidth	The frequency at which the output is attenuated by -3 dB.
On Response	The frequency response of the on switch.
On Loss	The voltage drop across the on switch seen in Figure 10 as the number of decibels that the signal is from 0 dB at very low frequencies.

TEST CIRCUITS

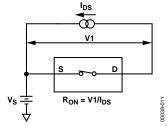


Figure 11. On Resistance

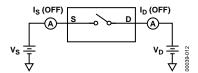


Figure 12. Off Leakage

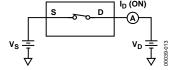


Figure 13. On Leakage

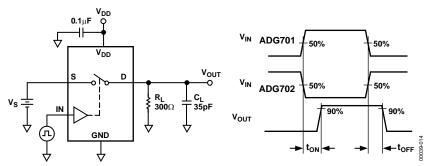


Figure 14. Switching Times

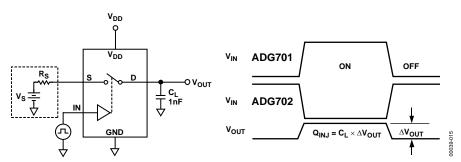
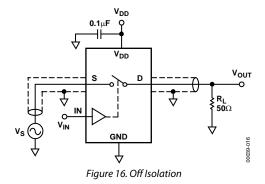


Figure 15. Charge Injection



 $V_{\rm DD}$ $V_{\rm DD}$

APPLICATIONS INFORMATION

The ADG701/ADG702 belong to the Analog Devices family of CMOS switches. This series of general-purpose switches has improved switching times, lower on resistance, higher bandwidth, low power consumption, and low leakage currents.

ADG701/ADG702 SUPPLY VOLTAGES

Functionality of the ADG701/ADG702 extends from 1.8 V to 5.5 V single supply, making the parts ideal for battery-powered instruments, where power efficiency and performance are important design parameters.

It is important to note that the supply voltage affects the input signal range, on resistance, and switching times of the part. The effects of the power supplies can be clearly seen in the Typical Performance Characteristics and the Specifications sections.

For V_{DD} = 1.8 V operation, R_{ON} is typically 40 Ω over the temperature range.

BANDWIDTH

Figure 18 illustrates the parasitic components that affect the ac performance of CMOS switches (a box surrounds the switch). Additional external capacitances further degrade performance by affecting feedthrough, crosstalk, and system bandwidth.

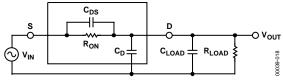


Figure 18. Switch Represented by Equivalent Parasitic Components

The transfer function that describes the equivalent diagram of the switch (see Figure 18) is of the form (A)s, shown in the following equation:

$$A(s) = R_T \left[\frac{s(R_{ON}C_{DS}) + 1}{s(R_{ON}C_TR_T) + 1} \right]$$

where $C_T = C_{LOAD} + C_D + C_{DS}$.

The signal transfer characteristic is dependent on the switch channel capacitance, C_{DS} . This capacitance creates a frequency zero in the numerator of the transfer function A(s). Because the switch on resistance is small, this zero usually occurs at high frequencies. The bandwidth is a function of the switch output capacitance combined with C_{DS} and the load capacitance. The frequency pole corresponding to these capacitances appears in the denominator of A(s).

The dominant effect of the output capacitance, C_D , causes the pole breakpoint frequency to occur first. To maximize bandwidth, a switch must have a low input and output capacitance and low on resistance. The on response vs. frequency for the ADG701/ADG702 can be seen in Figure 10.

OFF ISOLATION

Off isolation is a measure of the input signal coupled through an off switch to the switch output. The capacitance, C_{DS} , couples the input signal to the output load when the switch is off, as shown in Figure 19.

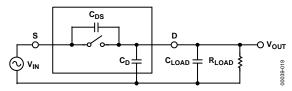
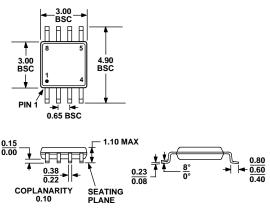


Figure 19. Off Isolation Is Affected by External Load Resistance and Capacitance

The larger the value of C_{DS} , the larger the values of feedthrough produced. Figure 9 illustrates the drop in off isolation as a function of frequency. From dc to roughly 1 MHz, the switch shows better than -75 dB isolation. Up to frequencies of 10 MHz, the off isolation remains better than -55 dB. As the frequency increases, more of the input signal is coupled through to the output. Off isolation can be maximized by choosing a switch with the smallest C_{DS} possible. The values of load resistance and capacitance also affect off isolation, because they contribute to the coefficients of the poles and zeros in the transfer function of the switch when open.

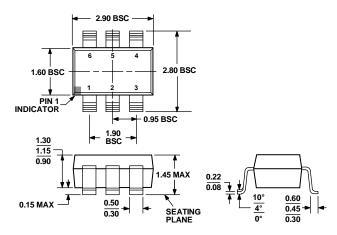
$$A(s) = R_T \left[\frac{s(R_{LOAD}C_{DS}) + 1}{s(R_{LOAD})(C_T) + 1} \right]$$

OUTLINE DIMENSIONS



COMPLIANT TO JEDEC STANDARDS MO-187-AA

Figure 20. 8-Lead Mini Small Outline Package [MSOP] (RM-8) Dimensions shown in millimeters



COMPLIANT TO JEDEC STANDARDS MO-178-AB

Figure 21. 6-Lead Small Outline Transistor Package [SOT-23] (RT-6) Dimensions shown in millimeters

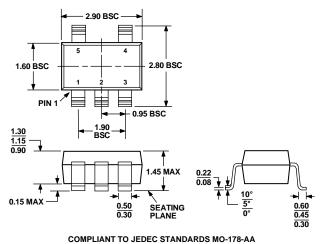


Figure 22. 5-Lead Small Outline Transistor Package [SOT-23]

(RJ-5)
Dimensions shown in millimeters

ORDERING GUIDE

Model	Package Description	Package Option	Branding
ADG701BRJ-500RL7	5-Lead Small Outline Transistor Package [SOT-23]	RJ-5	S3B
ADG701BRJ-REEL	5-Lead Small Outline Transistor Package [SOT-23]	RJ-5	S3B
ADG701BRJ-REEL7	5-Lead Small Outline Transistor Package [SOT-23]	RJ-5	S3B
ADG701BRM	8-Lead Mini Small Outline Package [MSOP]	RM-8	S3B
ADG701BRM-REEL	8-Lead Mini Small Outline Package [MSOP]	RM-8	S3B
ADG701BRM-REEL7	8-Lead Mini Small Outline Package [MSOP]	RM-8	S3B
ADG701BRT-REEL	6-Lead Small Outline Transistor Package [SOT-23]	RT-6	S3B
ADG701BRT-REEL7	6-Lead Small Outline Transistor Package [SOT-23]	RT-6	S3B
ADG701BRJZ-500RL7 ¹	5-Lead Small Outline Transistor Package [SOT-23]	RJ-5	S3B#
ADG701BRJZ-REEL ¹	5-Lead Small Outline Transistor Package [SOT-23]	RJ-5	S3B#
ADG701BRJZ-REEL71	5-Lead Small Outline Transistor Package [SOT-23]	RJ-5	S3B#
ADG701BRMZ ¹	8-Lead Mini Small Outline Package [MSOP]	RM-8	SOS
ADG701BRMZ-REEL7 ¹	8-Lead Mini Small Outline Package [MSOP]	RM-8	SOS
ADG701BRTZ-REEL ¹	6-Lead Small Outline Transistor Package [SOT-23]	RT-6	S3B#
ADG701BRTZ-REEL7 ¹	6-Lead Small Outline Transistor Package [SOT-23]	RT-6	S3B#
ADG702BRJ-500RL7	5-Lead Small Outline Transistor Package [SOT-23]	RJ-5	S4B
ADG702BRJ-REEL	5-Lead Small Outline Transistor Package [SOT-23]	RJ-5	S4B
ADG702BRJ-REEL7	5-Lead Small Outline Transistor Package [SOT-23]	RJ-5	S4B
ADG702BRM	8-Lead Mini Small Outline Package [MSOP]	RM-8	S4B
ADG702BRM-REEL	8-Lead Mini Small Outline Package [MSOP]	RM-8	S4B
ADG702BRM-REEL7	8-Lead Mini Small Outline Package [MSOP]	RM-8	S4B
ADG702BRT-REEL	6-Lead Small Outline Transistor Package [SOT-23]	RT-6	S4B
ADG702BRT-REEL7	6-Lead Small Outline Transistor Package [SOT-23]	RT-6	S4B
ADG702BRJZ-500RL7 ¹	5-Lead Small Outline Transistor Package [SOT-23]	RJ-5	S14
ADG702BRJZ-REEL ¹	5-Lead Small Outline Transistor Package [SOT-23]	RJ-5	S14
ADG702BRJZ-REEL7 ¹	5-Lead Small Outline Transistor Package [SOT-23]	RJ-5	S14
ADG702BRMZ ¹	8-Lead Mini Small Outline Package [MSOP]	RM-8	S14
ADG702BRMZ-REEL7 ¹	8-Lead Mini Small Outline Package [MSOP]	RM-8	S14
ADG702BRTZ-REEL ¹	6-Lead Small Outline Transistor Package [SOT-23]	RT-6	S4B#
ADG702BRTZ-REEL7 ¹	6-Lead Small Outline Transistor Package [SOT-23]	RT-6	S4B#

 $^{^1}$ Z = Pb-free part, # denotes lead-free product, may be top or bottom marked.

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